

	CL		4
Data	อก	œen	

December 2001

3.5A, 200V, 0.800 Ohm, N-Channel Power MOSFET

The 2N6790 is an N-Channel enhancement mode silicon gate power MOS field effect transistor designed for applications such as switching regulators, switching converters, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. This device can be operated directly from an integrated circuit.

Ordering Information

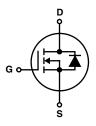
PART NUMBER	PACKAGE	BRAND
2N6790	TO-205AF	2N6790

NOTE: When ordering, include the entire part number.

Features

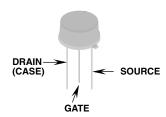
- 3.5A, 200V
- $r_{DS(ON)} = 0.800\Omega$
- SOA is Power Dissipation Limited
- · Nanosecond Switching Speeds
- Linear Transfer Characteristics
- · High Input Impedance
- · Majority Carrier Device
- · Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

Symbol



Packaging

JEDEC TO-205AF



Absolute Maximum Ratings $T_C = 25^{\circ}C$, Unless Otherwise Specified

	2N6790	UNITS
Drain to Source Voltage	200	V
Drain to Gate Voltage ($R_{GS} = 20k\Omega$) V_{DGR}	200	V
Continuous Drain Current	3.5	Α
$T_C = 100^{\circ}C$	2.25	Α
Pulsed Drain Current	14	Α
Gate to Source Voltage	±20	V
Continuous Source Current (Body Diode)	3.5	Α
Pulse Source Current (Body Diode)	14	Α
Maximum Power Dissipation	20	W
Above T _C = 25 ^o C, Derate Linearly	0.16	W/oC
Operating and Storage Temperature	-55 to 150	°C
Maximum Temperature for Soldering		
Leads at 0.063in (1.6mm) from Case for 10s	300	οС
Package Body for 10s, See Techbrief 334	260	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^{\circ}C$ to $125^{\circ}C$.

Electrical Specifications $T_C = 25^{\circ}C$, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV _{DSS}	I _D = 0.25mA, V _{GS} = 0V		200	-	-	V
Gate to Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 1.0$ mA		2	-	4	V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} = 200V, V _{GS} = 0V		-	-	250	μΑ
		V _{DS} = 160V, V _{GS} = 0V	T _C = 125 ^o C	-	-	1000	μΑ
Gate to Source Leakage Current	I _{GSS}	$V_{GS} = \pm 20V, V_{DS} = 0$		-	-	100	nA
Drain to Source On-Voltage (Note 2)	V _{DS(ON)}	$I_D = 3.5A, V_{GS} = 10V$		-	-	2.8	V
Drain to Source On Resistance	r _{DS(ON)}	I _D = 2.25A, V _{GS} = 10V		-	.5	0.800	Ω
		I _D = 2.25A, V _{GS} = 10V	$T_{C} = 125^{\circ}C$	-	-	1.5	Ω
Diode Forward Voltage	V _{SD}	$I_S = 3.5A, V_{GS} = 0V$		0.7	-	1.5	V
Forward Transconductance (Note 2)	9fs	I _D = 2.25A, V _{DS} = 5V		1.5	2.25	4.5	S
Input Capacitance	C _{ISS}	$V_{GS} = 0V$, $V_{DS} = 25V$ f = 1MHz		200	450	600	pF
Output Capacitance	C _{OSS}			60	150	300	pF
Reverse-Transfer Capacitance	C _{RSS}			15	40	80	pF
Turn-On Delay Time	t _{d(ON)}	$I_D = 2.25A$ $V_{GS} \cong 74V$, $R_G = 50\Omega$		-	-	40	ns
Rise Time	t _r			-	-	50	ns
Turn-Off Delay Time	t _{d(OFF)}				-	50	ns
Fall Time	t _f			-	-	50	ns
Safe Operating Area	SOA	$V_{DS} = 160V, I_D = 125mA$ $V_{DS} = 5.7V, I_D = 3.5A$		20	-	-	W
				20	-	-	W
Thermal Resistance Junction to Case	$R_{\theta JC}$			-	-	6.25	°C/W
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	Free Air Operation		-	-	175	°C/W

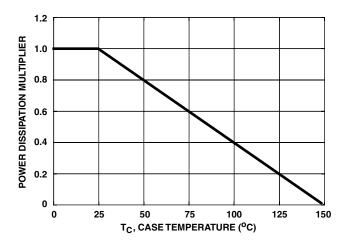
Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Reverse Recovery Time	t _{rr}	$T_J = 150^{o}C$, $I_{SD} = 3.5A$, $dI_{SD}/dt = 100A/\mu s$		350	-	ns
Reverse Recovered Charge	Q_{RR}	$TJ = 150^{\circ}C$, $I_{SD} = 3.5A$, $dI_{SD}/dt = 100A/\mu s$		2.3	-	μC

NOTES:

- 2. Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
- 3. Repetitive rating: pulse width limited by maximum junction temperature. See Transient Thermal Impedance curve (Figure 3).

Typical Performance Curves Unless Otherwise Specified



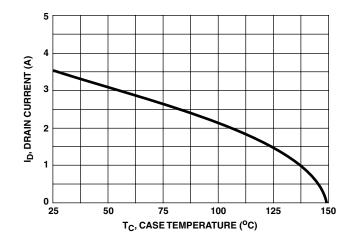


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE

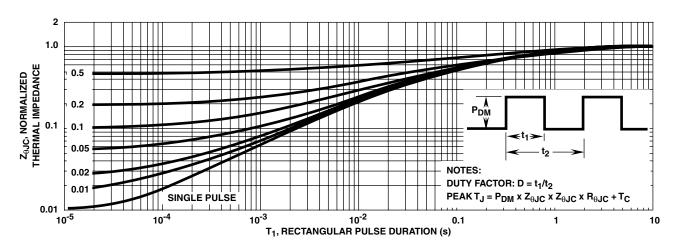


FIGURE 3. MAXIMUM TRANSIENT THERMAL IMPEDANCE

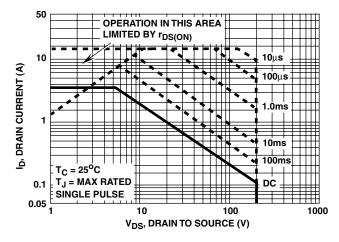


FIGURE 4. FORWARD BIAS SAFE OPERATING AREAS

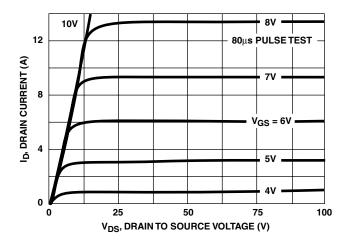


FIGURE 5. OUTPUT CHARACTERISTICS

Typical Performance Curves Unless Otherwise Specified (Continued)

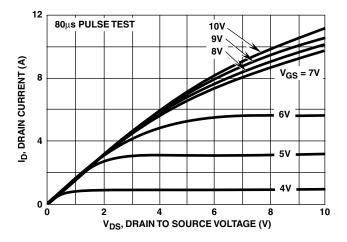


FIGURE 6. SATURATION CHARACTERISTICS

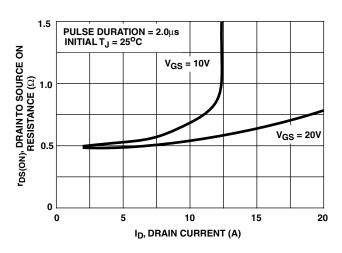


FIGURE 8. DRAIN TO SOURCE ON RESISTANCE vs GATE VOLTAGE AND DRAIN CURRENT

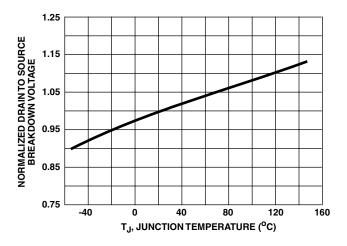


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE vs JUNCTION TEMPERATURE

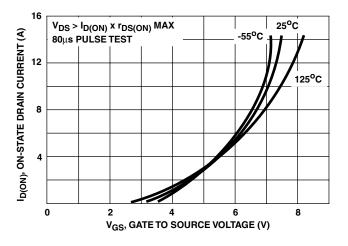


FIGURE 7. TRANSFER CHARACTERISTICS

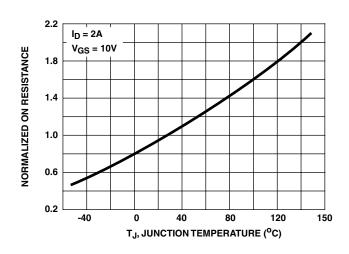


FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE vs JUNCTION TEMPERATURE

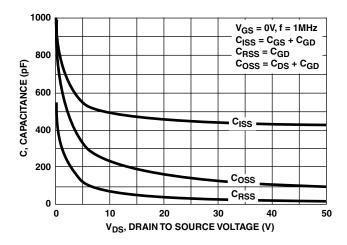
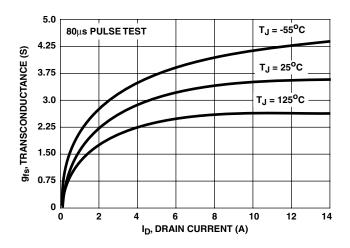


FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE

Typical Performance Curves Unless Otherwise Specified (Continued)



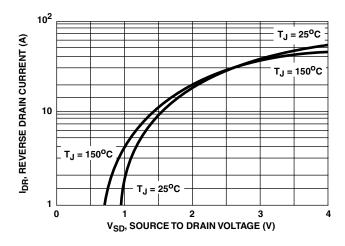


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

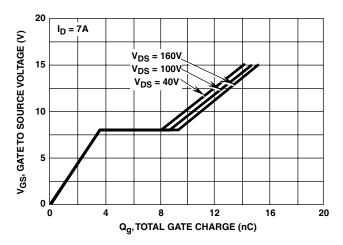


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

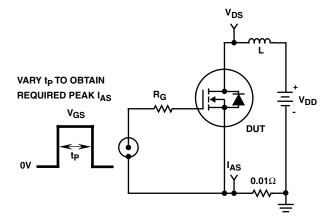


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

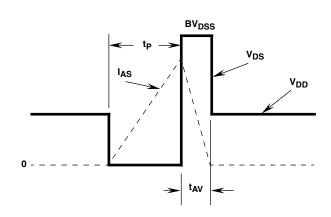


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

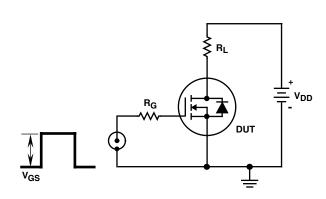


FIGURE 17. SWITCHING TIME TEST CIRCUIT

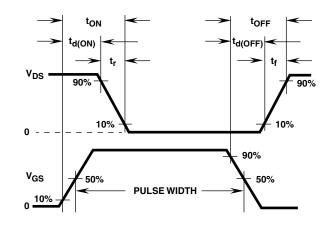


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

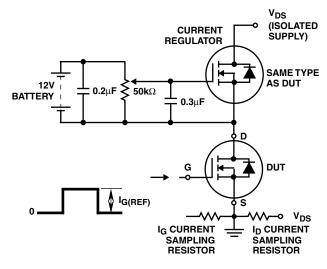


FIGURE 19. GATE CHARGE TEST CIRCUIT

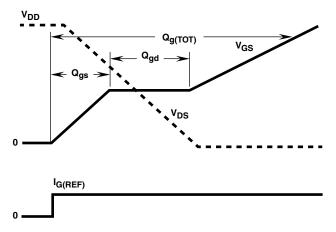


FIGURE 20. GATE CHARGE WAVEFORMS

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

SMART START™ VCX^{TM} FAST ® OPTOLOGIC™ STAR*POWER™ FASTr™ Bottomless™ OPTOPLANAR™ Stealth™ CoolFET™ FRFET™ PACMAN™ SuperSOT™-3 CROSSVOLT™ GlobalOptoisolator™ POP™ SuperSOT™-6 DenseTrench™ GTO™ Power247™ $HiSeC^{TM}$ SuperSOT™-8 $Power Trench^{\, @}$ DOME™ SyncFET™ EcoSPARK™ ISOPLANAR™ QFET™ TinyLogic™ E²CMOSTM LittleFET™ OS^{TM} TruTranslation™

STAR*POWER is used under license

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

Rev. H4